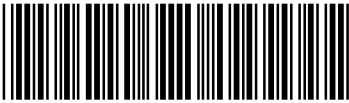


Search Notes

Application/Control No.

10/573,981

Examiner

Christian A. Hannon

Applicant(s)/Patent under
Reexamination

OKUMURA ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	151.1	2/20/2008	CH
455	154.1	2/20/2008	
455	157.1	2/20/2008	
455	157.2	2/20/2008	
455	158.1	2/20/2008	
455	158.2	2/20/2008	
455	158.4	2/20/2008	
455	158.5	2/20/2008	
455	159.1	2/20/2008	
455	179.1	2/20/2008	
455	180.1	2/20/2008	
455	184.1	2/20/2008	
455	186.1	2/20/2008	
455	345	2/20/2008	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted E. Urban, See printout	2/20/2008	CH